

**Notice of References Cited**

Application/Control No.

10/527,638

Applicant(s)/Patent Under  
Reexamination  
BALAYA ET AL.

Examiner

Ben Lewis

Art Unit

1795

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,756,155 B1	06-2004	Kweon et al.	429/231.95
*	B	US-2002/0102464 A1	08-2002	Yoshida et al.	429/300
*	C	US-2004/0214084 A1	10-2004	Barker et al.	429/218.1
*	D	US-2002/0192551 A1	12-2002	Yoshizawa et al.	429/221
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.